



1200V SiC MOSFET

V _{DS}	1200 V
R _{DS,on}	18.0 mΩ
I _{D (TC=25C)}	119 A
T _j ,max	175°C

Features

- High speed switching
- Reliable body diode
- All parts tested to greater than 1,400V
- Avalanche tested to 800mJ*
- Driver source pin for gate driving

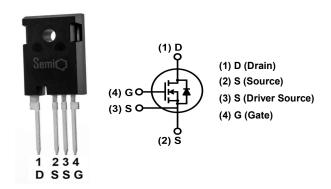
Benefits

- Lower capacitance
- Higher system efficiency
- Easy to parallel
- Lower Switching Loss
- · Longer creepage distance

Applications

- Solar Inverters
- Switch mode power supplies, UPS
- · Induction heating and welding
- EV charging stations
- High voltage DC/DC converters
- · Motor drives

Package



Part #	Package	Marking
GP2T020A120H	TO-247-4L	2T020A120H



Maximum Ratings, at T_j =25°C, unless otherwise specified

Characteristics	Symbol	Conditions	Values	Unit	
Drain-Source Voltage	V _{rated}	V _{GS} =0V, I _{DS} =1μA	1200	V	
Continuous Drain Current	ı	T _C =25 °C, T _j =175 °C	119		
Continuous Diain Current	l _D	T _C =100 °C, T _j =175 °C	86	Α	
Pulsed Drain Current	I _{D,pulse} *	T _C =25°C	250	7	
Octo Occurs Valtaria	V_{GSmax}		-10/25	V	
Gate Source Voltage	V_{GSop}	Recommended operational	-5/20	V	
Power Dissipation	P _{tot}	T _C =25°C	564	W	
Operating & Storage Temperature	T _{j,} T _{storage}	Continuous	-55175	°C	
Single Pulse Avalanche Energy	E _{AS}	L=1.0mH, I _{AS} =40.0A, V=50V	800	mJ	

Thermal Characteristics

Characteristics	Symbol	Conditions -	Values			Unit
Characteristics	Syllibol		min.	typ.	max.	O'III
Thermal Resistance, Junction to Case	R _{thJC}		-	0.22	0.27	
Thermal Resistance, Junction to Ambient	R _{thJA}		-	-	40.0	°C/W

^{*} Pulse width is limited by Tj_{max}

Static Electrical Characteristics, at T_j =25°C, unless otherwise specified

Characteristics	Cumbal	Conditions	Values			Unit	
Characteristics	Symbol	Conditions	min.	typ.	max.	Oille	
Drain-Source Breakdown Voltage	BV _{DSS}	I _{DS} =1mA	1200	-	-	V	
Zero Gate Voltage Drain Current	ı	V _{DS} =1200V, V _{GS} =0V	-	0.1	1.0		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =1200V, V _{GS} =0V, T _j =175°C	-	1	-	μA	
Cata Source Lookage Current	I _{GSS+}	V _{GS} =20V, V _{DS} =0V	-	<+10	100	nA	
Gate-Source Leakage Current	I _{GSS-}	V _{GS} =-5V, V _{DS} =0V	-	>-10	-100	I IIA	
	V _{GS(th)}	$V_{GS}=V_{DS}$, $I_{DS}=20$ mA	1.8	2.5	4	V	
Gate Threshold Voltage		$V_{GS}=V_{DS}$, $I_{DS}=20$ mA, $T_j=125$ °C	-	1.8	-		
		$V_{GS}=V_{DS}$, $I_{DS}=20$ mA, $T_j=175$ °C	-	1.6	-		
	R _{DSon}	V _{GS} =20V, I _{DS} =50A	-	18.0	28	- mΩ	
Drain-Source On-Resistance		V _{GS} =20V, I _{DS} =25A	-	17.6	26		
Diam-source On-Resistance		V _{GS} =20V, I _{DS} =50A, T _j =125°C	-	27	-		
		V _{GS} =20V, I _{DS} =50A, T _j =175°C	-	35	-		
Transconductance	g _{fs}	V _{DS} =20V, I _{DS} =50A	-	26	-	S	
Gate Input Resistance	R_{G}	f=1MHz, V _{AC} =25mV, D-S Short	-	0.8	-	Ω	

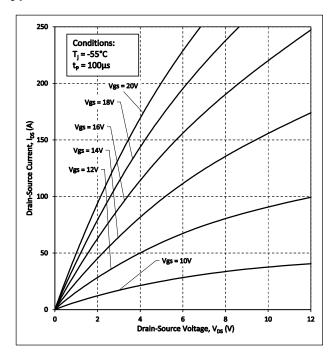
AC Electrical Characteristics, at T_j =25°C, unless otherwise specified

Characteristics	Symbol	Conditions		Values		
Citatacteristics	Symbol	Conditions	min.	typ.	max.	Unit
Input Capacitance	C _{ISS}	\/ -0\/	-	5584	-	
Output Capacitance	C _{OSS}	V _{GS} =0V, V _{DS} =1000V,	-	261	-	pF
Reverse Transfer Capacitance	C _{RSS}	f=200kHz, V _{AC} =25mV	-	16	-	
Coss Stored Energy	E _{oss}	1 200K12, V _{AC} 2011V	-	154	-	μJ
Turn-On Switching Energy	E _{ON}	V _{DD} =800V, I _{DS} =50A,	-	730	-	
Turn-Off Switching Energy	E _{OFF}	R _{G(ext)} =2.5, V _{GS} =-5/+20V, L=273μH,	-	105	-	μJ
Total Switching Energy	E _{TOT}	FWD=GP2T020A120H	-	835	-	1
Turn-On Switching Energy	E _{ON}	V _{DD} =800V, I _{DS} =50A,	-	485	-	
Turn-Off Switching Energy	E _{OFF}	R _{G(ext)} =2.5, V _{GS} =-5/+20V, L=273μH,	-	124	-	μJ
Total Switching Energy	E _{TOT}	FWD=GP3D020A120A	-	609	-	1
Turn-On Delay Time	t _{D(on)}	V _{DD} =800V, I _{DS} =50A,	-	17	-	
Rise Time	t _R	R _{G(ext)} =2.5, V _{GS} =-5/+20V,	-	5	-]
Turn-Off Delay Time	t _{D(off)}	L=273μH,	-	38	-	ns
Fall Time	t _F	FWD=GP2T020A120H	-	19	-]
Total Gate Charge	Q_G	V -900V I -50A	-	216	-	
Gate to Source Charge	Q _{GS}	V _{DD} =800V, I _{DS} =50A, V _{GS} =-5/+20V	-	74	-	nC
Gate to Drain Charge	Q_{GD}	VGS 0/120V	-	36	-	

Body Diode Characteristics, at Tj=25°C, unless otherwise specified

Characteristics	Symbol	Conditions	Values			Unit
Citatacteristics	Symbol	Conditions	min.	typ.	max.	Oilit
Max Continuous Diode Fwd Current	I _S	V_{GS} =-5V, T_C =25°C	-	-	131	Α
Diode Forward Voltage	V_{SD}	V_{GS} =-5V, I_{SD} =25A	-	3.6	-	V
Reverse Recovery Time	t _{RR}	-50A \/ -800\/ \/ - 5\/	-	12	-	ns
Reverse Recovery Charge	Q_{RR} I_{SD} =50A, V_{R} =800V, V_{GS} =-5V, I_{SD} =414.3A/ns		-	761	-	nC
Peak Reverse Recovery Current	I _{RRM}	14.07 (113	-	95	-	Α

Typical Performance



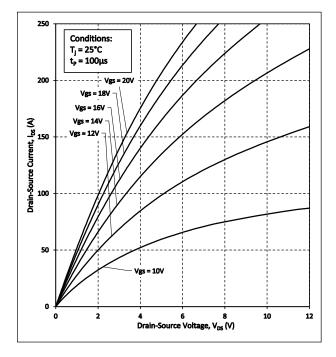


Figure 1. Output Characteristics T_i = -55°C

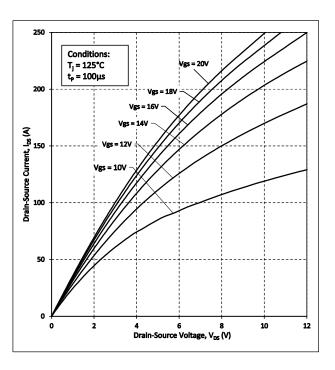


Figure 3. Output Characteristics $T_j = 125$ °C

Figure 2. Output Characteristics $T_i = 25^{\circ}C$

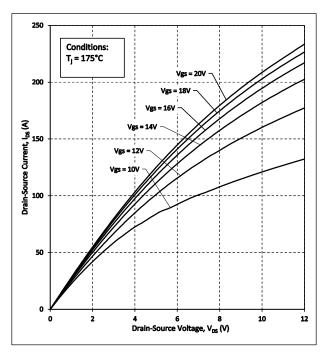


Figure 4. Output Characteristics $T_j = 175$ °C

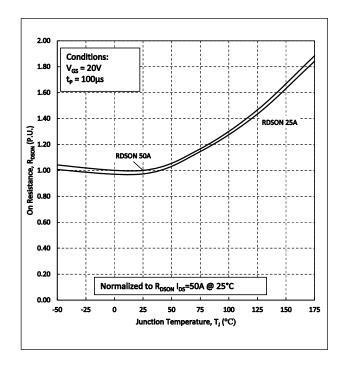


Figure 6. On-Resistance vs. Drain Current For

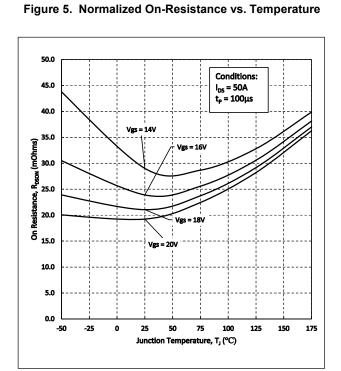


Figure 7. On-Resistance vs. Temperature For Various Gate Voltages

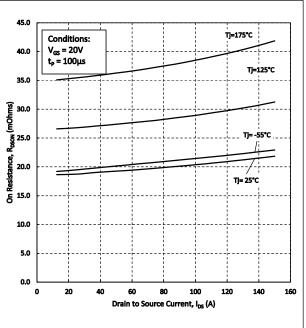


Figure 6. On-Resistance vs. Drain Current For Various Temperature

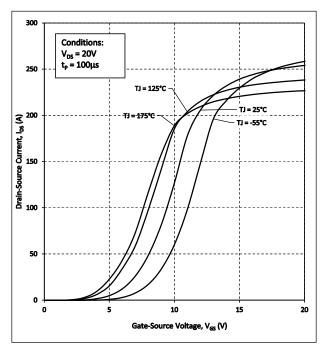
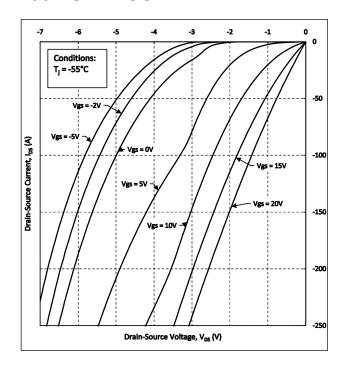


Figure 8. Transfer Characteristic for Various Junction Temperatures

GP2T020A120H



-7 -6 -5 -4 -3 -2 -1 0 0

Vgs = -2V

Vgs = 10V

Vgs = 15V

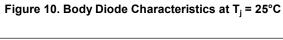
Vgs = 20V

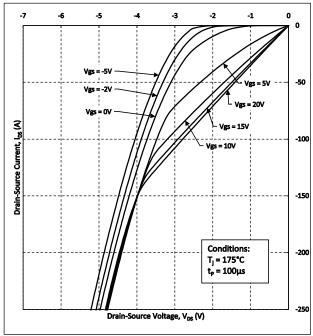
-150

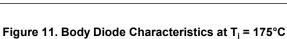
Conditions:
Τ_j = 25°C
τ_p = 100μs

-200

Figure 9. Body Diode Characteristics at T_i = -55°C







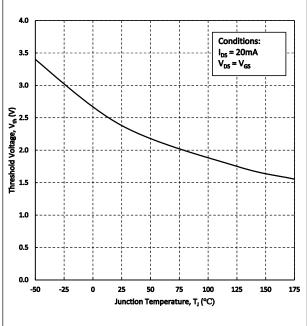
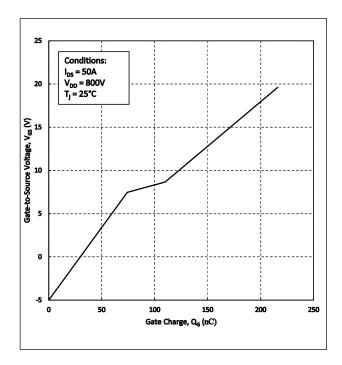


Figure 12. Threshold Voltage vs. Temperature



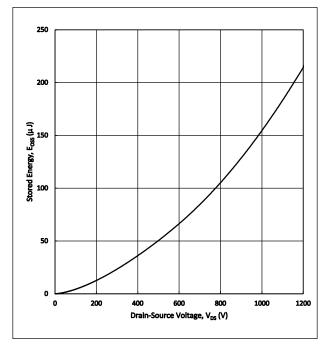


Figure 13. Gate Charge Characteristics

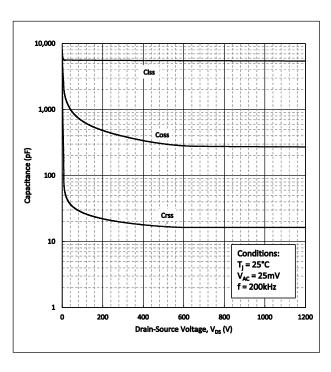


Figure 15. Capacitance vs Drain-Source Voltage

Figure 14. Output Capacitor Stored Energy

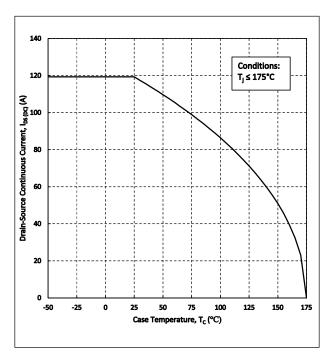


Figure 16. Continuous Drain Current Derating vs.

Case Temperature

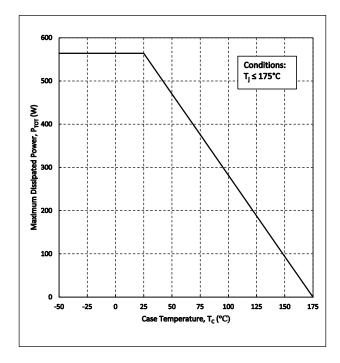


Figure 17. Maximum Power Dissipation Derating vs Case Temperature

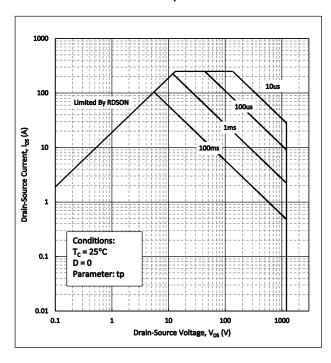


Figure 19. Safe Operating Area

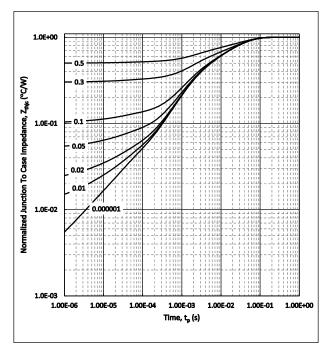


Figure 18. Transient Thermal impedance (Junction to Case)

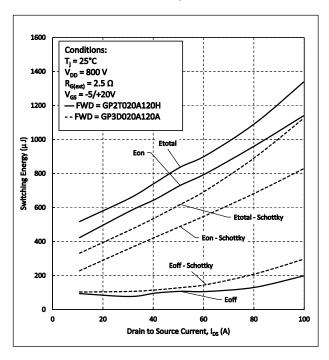


Figure 20. Clamped Inductive Switching Energy vs.

Drain Current

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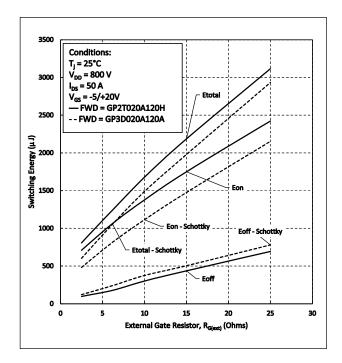


Figure 21. Clamped Inductive Switching Energy vs. $R_{\text{G(ext)}} \label{eq:RGext}$

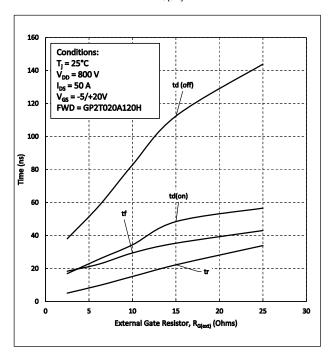


Figure 23. Switching Times vs R_{G(ext)}

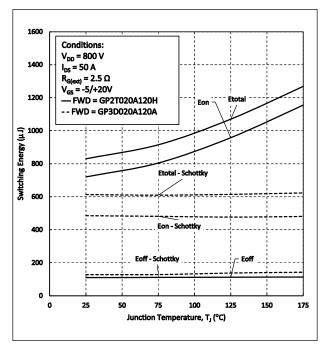


Figure 22. Clamped Inductive Switching Energy vs.
Temperature

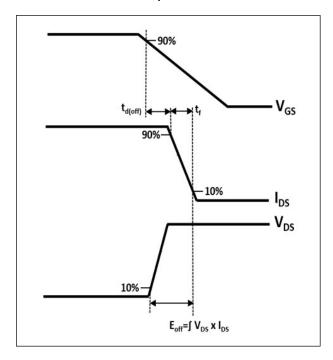
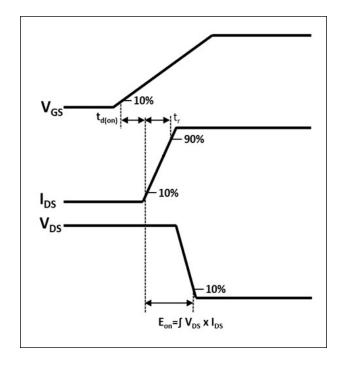


Figure 24. Turn-off Transient Definitions

GP2T020A120H



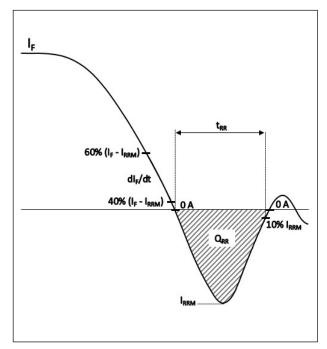
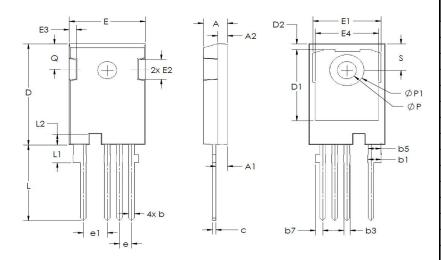


Figure 25. Turn-on Transient Definitions

Figure 26. Reverse Recovery Definitions

Package Dimensions TO-247-4L



Sym	Millin	neters	Inches		
Sylli	Min	Max	Min	Max	
Α	4.83	5.21	0.190	0.205	
A1	2.29	2.54	0.090	0.100	
A2	1.91	2.16	0.075	0.085	
b	1.07	1.33	0.042	0.052	
b1	2.39	2.94	0.094	0.116	
b3	1.07	1.60	0.042	0.063	
b5	2.39	2.69	0.094	0.106	
b7	1.30	1.70	0.051	0.067	
С	0.55	0.68	0.022	0.027	
c1	0.55	0.65	0.022	0.026	
D	23.30	23.60	0.917	0.929	
D1	16.25	17.65	0.640	0.695	
D2	0.95	1.25	0.037	0.049	
Е	15.75	16.13	0.620	0.635	
E3	1.00	1.90	0.039	0.075	
E4	12.38	13.43	0.487	0.529	
е	2.54 BSC		0.100	BSC	
e1	5.08	BSC	0.200	BSC	
L	17.31	17.82	0.681	0.702	
L1	3.97	4.37	0.156	0.172	
L2	2.35	2.65	0.093	0.104	
ØP	3.51	3.65	0.138	0.144	
ØP1	7.19	REF	0.283 REF		
Q	5.49	6.00	0.216	0.236	
S	6.04	6.30	0.238	0.248	

Notes

RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS2), as implemented March, 2013. RoHS Declarations for this product can be obtained from the Product Documentation sections of www.SemiQ.com.

REACh Compliance

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 $SemiQ\ qualification\ complies\ with\ JEDEC\ Standard\ conditions.\ This\ includes\ Temperature\ Cycle\ JESD22-A104\ Condition\ G.$